

Notice of References Cited	Application/Control No. 10/589,935		Applicant(s)/Patent Under Reexamination LUCAS ET AL.	
	Examiner CHRISTINE CHEN		Art Unit 1793	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0103159	05-2005	Ducrocq, Jean	075/385
*	C	US-6,245,122	06-2001	Meyers, Frederick N.	75/385
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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